

# **FQD10N20L / FQU10N20L**

## **200V LOGIC N-Channel MOSFET**

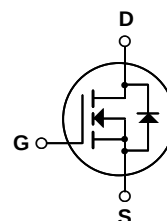
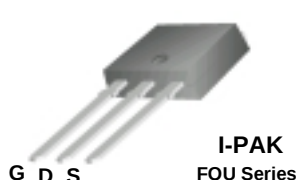
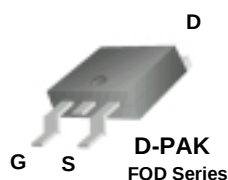
### **General Description**

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology is especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation modes. These devices are well suited for high efficiency switching DC/DC converters, switch mode power supplies, and motor control.

### **Features**

- 7.6A, 200V,  $R_{DS(on)} = 0.36\Omega$  @  $V_{GS} = 10V$
- Low gate charge ( typical 13 nC)
- Low  $C_{rss}$  ( typical 14 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability
- Low level gate drive requirement allowing direct operation from logic drivers



### **Absolute Maximum Ratings** $T_C = 25^\circ\text{C}$ unless otherwise noted

| Symbol         | Parameter                                                                     | FQD10N20L / FQU10N20L | Units               |
|----------------|-------------------------------------------------------------------------------|-----------------------|---------------------|
| $V_{DSS}$      | Drain-Source Voltage                                                          | 200                   | V                   |
| $I_D$          | Drain Current - Continuous ( $T_C = 25^\circ\text{C}$ )                       | 7.6                   | A                   |
|                | - Continuous ( $T_C = 100^\circ\text{C}$ )                                    | 4.8                   | A                   |
| $I_{DM}$       | Drain Current - Pulsed (Note 1)                                               | 30.4                  | A                   |
| $V_{GSS}$      | Gate-Source Voltage                                                           | $\pm 20$              | V                   |
| $E_{AS}$       | Single Pulsed Avalanche Energy (Note 2)                                       | 180                   | mJ                  |
| $I_{AR}$       | Avalanche Current (Note 1)                                                    | 7.6                   | A                   |
| $E_{AR}$       | Repetitive Avalanche Energy (Note 1)                                          | 5.1                   | mJ                  |
| dv/dt          | Peak Diode Recovery dv/dt (Note 3)                                            | 5.5                   | V/ns                |
| $P_D$          | Power Dissipation ( $T_A = 25^\circ\text{C}$ ) *                              | 2.5                   | W                   |
|                | Power Dissipation ( $T_C = 25^\circ\text{C}$ )                                | 51                    | W                   |
|                | - Derate above $25^\circ\text{C}$                                             | 0.4                   | W/ $^\circ\text{C}$ |
| $T_J, T_{STG}$ | Operating and Storage Temperature Range                                       | -55 to +150           | $^\circ\text{C}$    |
| $T_L$          | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds | 300                   | $^\circ\text{C}$    |

### **Thermal Characteristics**

| Symbol          | Parameter                                 | Typ | Max  | Units              |
|-----------------|-------------------------------------------|-----|------|--------------------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case      | --  | 2.48 | $^\circ\text{C/W}$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient * | --  | 50   | $^\circ\text{C/W}$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient   | --  | 110  | $^\circ\text{C/W}$ |

\* When mounted on the minimum pad size recommended (PCB Mount)

**Electrical Characteristics** $T_C = 25^\circ\text{C}$  unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|--------|-----------|-----------------|-----|-----|-----|-------|
|--------|-----------|-----------------|-----|-----|-----|-------|

**Off Characteristics**

|                                |                                           |                                                                   |     |      |      |                     |
|--------------------------------|-------------------------------------------|-------------------------------------------------------------------|-----|------|------|---------------------|
| $BV_{DSS}$                     | Drain-Source Breakdown Voltage            | $V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$               | 200 | --   | --   | V                   |
| $\Delta BV_{DSS} / \Delta T_J$ | Breakdown Voltage Temperature Coefficient | $I_D = 250\text{ }\mu\text{A}$ , Referenced to $25^\circ\text{C}$ | --  | 0.18 | --   | V/ $^\circ\text{C}$ |
| $I_{DSS}$                      | Zero Gate Voltage Drain Current           | $V_{DS} = 200\text{ V}, V_{GS} = 0\text{ V}$                      | --  | --   | 1    | $\mu\text{A}$       |
|                                |                                           | $V_{DS} = 160\text{ V}, T_C = 125^\circ\text{C}$                  | --  | --   | 10   | $\mu\text{A}$       |
| $I_{GSSF}$                     | Gate-Body Leakage Current, Forward        | $V_{GS} = 20\text{ V}, V_{DS} = 0\text{ V}$                       | --  | --   | 100  | nA                  |
| $I_{GSSR}$                     | Gate-Body Leakage Current, Reverse        | $V_{GS} = -20\text{ V}, V_{DS} = 0\text{ V}$                      | --  | --   | -100 | nA                  |

**On Characteristics**

|              |                                   |                                                    |     |      |      |          |
|--------------|-----------------------------------|----------------------------------------------------|-----|------|------|----------|
| $V_{GS(th)}$ | Gate Threshold Voltage            | $V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$    | 1.0 | --   | 2.0  | V        |
| $R_{DS(on)}$ | Static Drain-Source On-Resistance | $V_{GS} = 10\text{ V}, I_D = 3.8\text{ A}$         | --  | 0.29 | 0.36 | $\Omega$ |
|              |                                   | $V_{GS} = 5\text{ V}, I_D = 3.8\text{ A}$ (Note 4) | --  | 0.3  | 0.38 | $\Omega$ |
| $g_{FS}$     | Forward Transconductance          | $V_{DS} = 30\text{ V}, I_D = 3.8\text{ A}$         | --  | 9.6  | --   | S        |

**Dynamic Characteristics**

|           |                              |                                                                      |    |     |     |    |
|-----------|------------------------------|----------------------------------------------------------------------|----|-----|-----|----|
| $C_{iss}$ | Input Capacitance            | $V_{DS} = 25\text{ V}, V_{GS} = 0\text{ V},$<br>$f = 1.0\text{ MHz}$ | -- | 640 | 830 | pF |
| $C_{oss}$ | Output Capacitance           |                                                                      | -- | 95  | 125 | pF |
| $C_{rss}$ | Reverse Transfer Capacitance |                                                                      | -- | 14  | 18  | pF |

**Switching Characteristics**

|              |                     |                                                                                     |    |     |     |    |
|--------------|---------------------|-------------------------------------------------------------------------------------|----|-----|-----|----|
| $t_{d(on)}$  | Turn-On Delay Time  | $V_{DD} = 100\text{ V}, I_D = 10\text{ A},$<br>$R_G = 25\text{ }\Omega$ (Note 4, 5) | -- | 13  | 35  | ns |
| $t_r$        | Turn-On Rise Time   |                                                                                     | -- | 150 | 310 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time |                                                                                     | -- | 50  | 110 | ns |
| $t_f$        | Turn-Off Fall Time  |                                                                                     | -- | 95  | 200 | ns |
| $Q_g$        | Total Gate Charge   | $V_{DS} = 160\text{ V}, I_D = 10\text{ A},$<br>$V_{GS} = 5\text{ V}$ (Note 4, 5)    | -- | 13  | 17  | nC |
| $Q_{gs}$     | Gate-Source Charge  |                                                                                     | -- | 2.4 | --  | nC |
| $Q_{gd}$     | Gate-Drain Charge   |                                                                                     | -- | 6.1 | --  | nC |

**Drain-Source Diode Characteristics and Maximum Ratings**

|                 |                                                       |                                                        |    |      |      |    |
|-----------------|-------------------------------------------------------|--------------------------------------------------------|----|------|------|----|
| I <sub>S</sub>  | Maximum Continuous Drain-Source Diode Forward Current |                                                        | -- | --   | 7.6  | A  |
| I <sub>SM</sub> | Maximum Pulsed Drain-Source Diode Forward Current     |                                                        | -- | --   | 30.4 | A  |
| V <sub>SD</sub> | Drain-Source Diode Forward Voltage                    | V <sub>GS</sub> = 0 V, I <sub>S</sub> = 7.6 A          | -- | --   | 1.5  | V  |
| t <sub>rr</sub> | Reverse Recovery Time                                 | V <sub>GS</sub> = 0 V, I <sub>S</sub> = 10 A, (Note 4) | -- | 120  | --   | ns |
| Q <sub>rr</sub> | Reverse Recovery Charge                               | dI <sub>F</sub> / dt = 100 A/μs                        | -- | 0.57 | --   | μC |

**Notes:**

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2.  $L = 4.7\text{ mH}, I_{AS} = 7.6\text{ A}, V_{DD} = 50\text{ V}, R_G = 25\text{ }\Omega$ , Starting  $T_J = 25^\circ\text{C}$
3.  $I_{SD} \leq 10\text{ A}, dI/dt \leq 300\text{ A}/\mu\text{s}, V_{DD} \leq BV_{DSS}$ , Starting  $T_J = 25^\circ\text{C}$
4. Pulse Test : Pulse width  $\leq 300\mu\text{s}$ , Duty cycle  $\leq 2\%$
5. Essentially independent of operating temperature

## Typical Characteristics

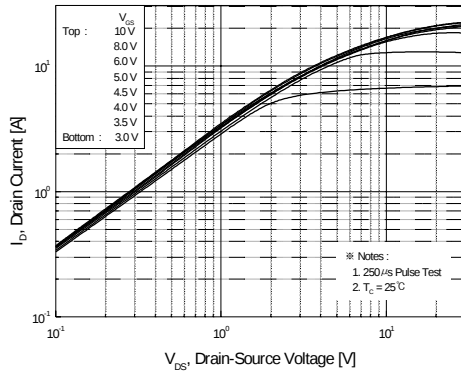


Figure 1. On-Region Characteristics

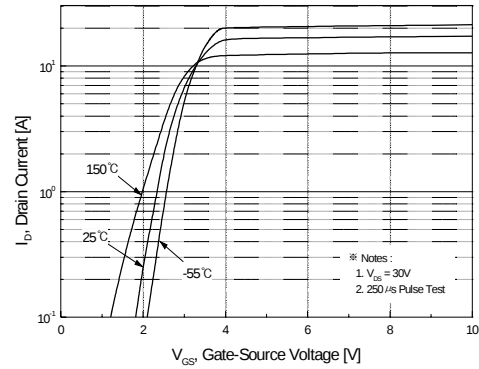


Figure 2. Transfer Characteristics

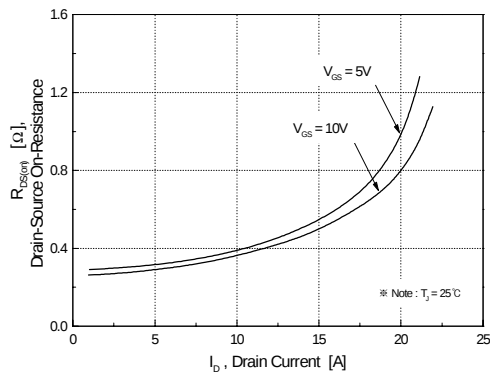


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

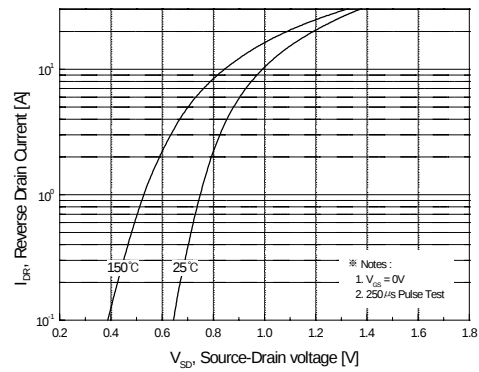


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

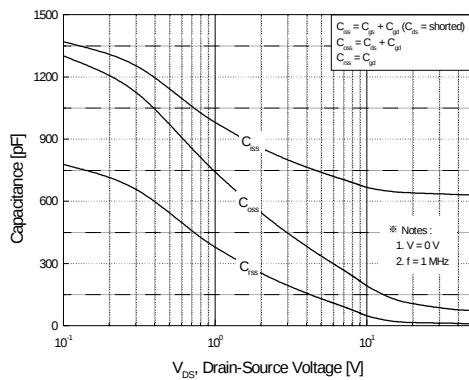


Figure 5. Capacitance Characteristics

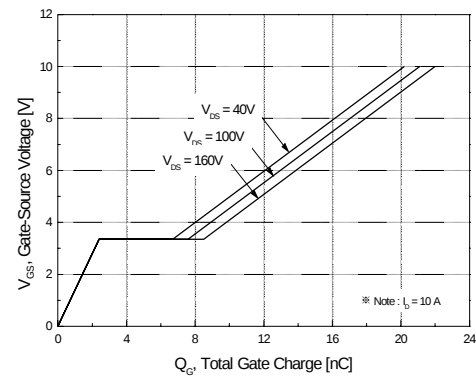
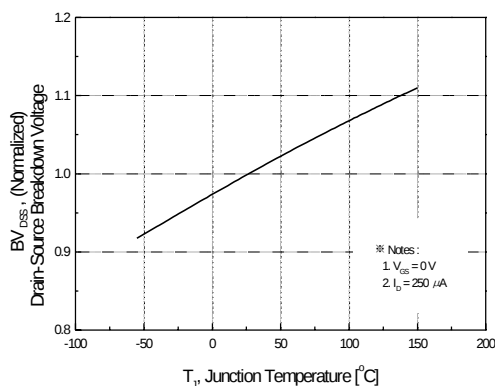
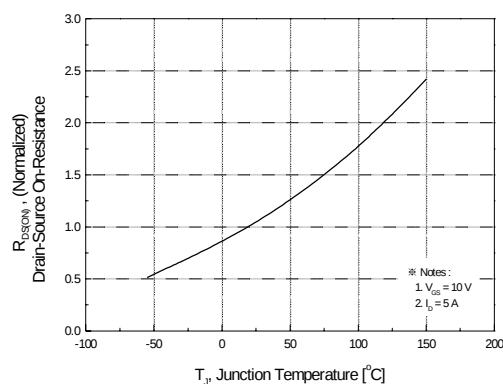


Figure 6. Gate Charge Characteristics

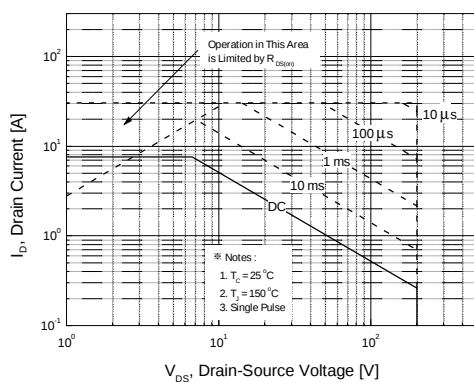
## Typical Characteristics (Continued)



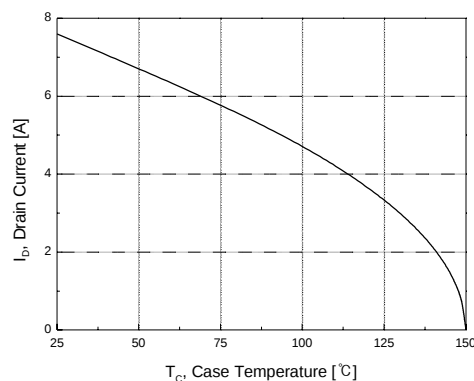
**Figure 7. Breakdown Voltage Variation vs. Temperature**



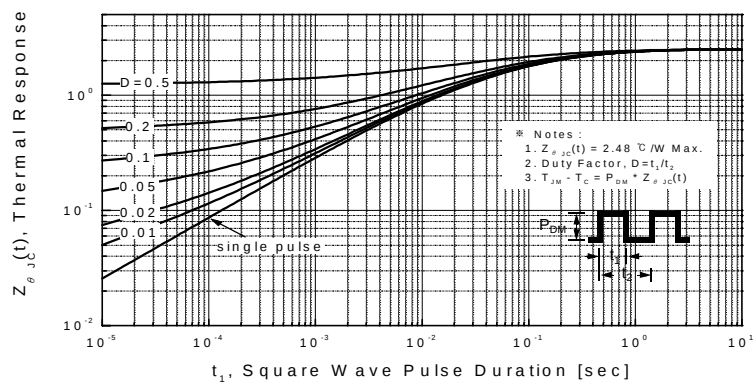
**Figure 8. On-Resistance Variation vs. Temperature**



**Figure 9. Maximum Safe Operating Area**



**Figure 10. Maximum Drain Current vs. Case Temperature**



**Figure 11. Transient Thermal Response Curve**

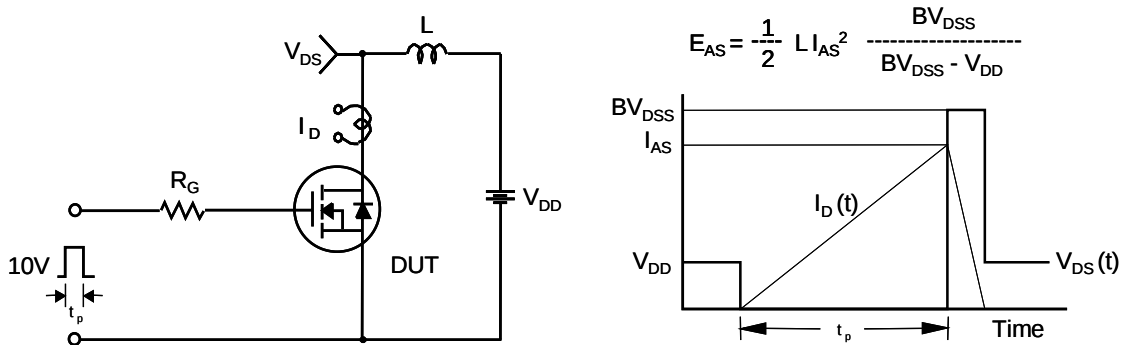
### Gate Charge Test Circuit & Waveform



### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching Test Circuit & Waveforms





**FQD10N20L / FQU10N20L**

[illegible]

Technical drawing of a 3-pin connector showing front, side, and top views with dimensions in millimeters.

**Front View Dimensions:**

- Overall width:  $6.60 \pm 0.20$
- Distance between pins:  $5.34 \pm 0.20$
- Pin width:  $0.76 \pm 0.10$
- Pin spacing (typical):  $2.30 \text{ TYP}$  [2.30 ± 0.20]
- Pin length:  $16.10 \pm 0.30$
- Pin diameter:  $0.80 \pm 0.10$
- Pin tip radius:  $0.76 \pm 0.10$
- Pin base width:  $0.76 \pm 0.10$
- Pin base length:  $0.80 \pm 0.10$
- Pin base thickness:  $0.60 \pm 0.20$
- Pin base height:  $0.70 \pm 0.20$
- Pin base width (typical):  $2.30 \text{ TYP}$  [2.30 ± 0.20]
- Pin base length (typical):  $2.30 \text{ TYP}$  [2.30 ± 0.20]
- Pin base thickness (typical):  $2.30 \text{ TYP}$  [2.30 ± 0.20]
- Pin base height (typical):  $2.30 \text{ TYP}$  [2.30 ± 0.20]
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- Pin base length (typical):  $2.30 \text{ TYP}$  [2.30 ± 0.20]
- Pin base thickness (typical):  $2.30 \text{ TYP}$  [2.30 ± 0.20]
- Pin base height (typical):  $2.30 \text{ TYP}$  [2.30 ± 0.20]

**Side View Dimensions:**

- Overall height:  $2.30 \pm 0.20$
- Pin height:  $0.50 \pm 0.10$
- Pin width:  $0.50 \pm 0.10$
- Pin length:  $16.10 \pm 0.30$
- Pin diameter:  $0.80 \pm 0.10$
- Pin tip radius:  $0.76 \pm 0.10$
- Pin base width:  $0.76 \pm 0.10$
- Pin base length:  $0.80 \pm 0.10$
- Pin base thickness:  $0.60 \pm 0.20$
- Pin base height:  $0.70 \pm 0.20$
- Pin base width (typical):  $2.30 \text{ TYP}$  [2.30 ± 0.20]
- Pin base length (typical):  $2.30 \text{ TYP}$  [2.30 ± 0.20]
- Pin base thickness (typical):  $2.30 \text{ TYP}$  [2.30 ± 0.20]
- Pin base height (typical):  $2.30 \text{ TYP}$  [2.30 ± 0.20]

**Top View Dimensions:**

- Overall width:  $6.60 \pm 0.20$
- Distance between pins:  $5.34 \pm 0.20$
- Pin width:  $0.76 \pm 0.10$
- Pin spacing (typical):  $2.30 \text{ TYP}$  [2.30 ± 0.20]
- Pin length:  $16.10 \pm 0.30$
- Pin diameter:  $0.80 \pm 0.10$
- Pin tip radius:  $0.76 \pm 0.10$
- Pin base width:  $0.76 \pm 0.10$
- Pin base length:  $0.80 \pm 0.10$
- Pin base thickness:  $0.60 \pm 0.20$
- Pin base height:  $0.70 \pm 0.20$
- Pin base width (typical):  $2.30 \text{ TYP}$  [2.30 ± 0.20]
- Pin base length (typical):  $2.30 \text{ TYP}$  [2.30 ± 0.20]
- Pin base thickness (typical):  $2.30 \text{ TYP}$  [2.30 ± 0.20]
- Pin base height (typical):  $2.30 \text{ TYP}$  [2.30 ± 0.20]

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